

Form PTO-1448
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APR 19 2004
U.S. PATENT & TRADEMARK OFFICE

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
3493-CON1

SERIAL NO.
10/053,201

LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT
Harry Rosenberg et al

FILING DATE
January 13, 2007

GROUP
2818

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
PD	4,128,421	12/05/1978	Marsh et al	—	—	
PD	5,948,216	09/07/1999	Cava et al	—	—	
PD	5,242,481	09/07/1993	Kumar	—	—	
AD						
AE						
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AG						
AH						
AI						

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
AJ							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

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7/21/04

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PMA PTO-1448		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 34391-CONT	SERIAL NO. 100313291		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT HARRY ROMOLDO JR. ET AL			
				FILING DATE January 15, 2003		GROUP 2010	
U.S. PATENT DOCUMENTS							
Examiner Initials		Document Number	Date	Patent	Class	Subclass	Filing Date if Applicable
PD	AA	2,930,143	09/1960	RE41514 et al	—	—	
PD	AB	5,030,166	06/1997	6,013,020 et al	—	—	
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FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
PD	AL	EP 0307102	03/1999	EPO			Yes No
	AS						
OTHER REFERENCES (including Author, Title, Date, Page, etc.)							
PD	AL	Clark et al, "Influence of Hot-rolled Ingot Breakdown on the Microstructural and Textural Development of High Purity Tantalum", Metallurgical transactions, vol. 22A, pp. 2959-2968, December 1991.					
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EXAMINER PHUC T. DANG				DATE CONSIDERED 7/21/04			
*EXAMINER: initial if reference considered, whether or not citation is in conformance with MPEP 600; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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Form PTO-1440

WELLS ST. JOHN, P.S.

U.S. DEPARTMENT OF COMMERCE
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LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)ATTY. DOCKET NO.
34593-CON1SERIAL NO.
(0051, 201)APPLICANT
Harry Rosenberg et alFILING DATE
January 15, 2002GROUP
2818

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
PD	AA	3,196,163	03/1993	Matsum et al			
PD	AB	5,040,861	01/1992	Garde			
	AC						
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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Page, Etc.)

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PHUC T. DANG

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 34593-CON1	SERIAL NO. 10051201		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Harry Rosenberg et al			
				PILING DATE January 15, 2004	GROUP 2018		
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Applicable
PD	AA	6,170,451	10/2000	Hasegawa, Toshiaki	—	—	
	AB						
	AC						
	AD						
	AE						
	AP						
	AG						
	AH						
	AJ						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
	AJ						Yes
	AK						No
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER		PHUC T. DANG		DATE CONSIDERED		7/21/04	
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